

<b>Notice of References Cited</b>	Application/Control No. 10/569,839	Applicant(s)/Patent Under Reexamination SEH ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0132325 A1	07-2004	Yu et al.	439/140
*	B	US-6,942,503 B2	09-2005	Yamaguchi et al.	439/141
*	C	US-4,217,019	08-1980	Cameron, John K.	439/138
*	D	US-2004/0067667 A1	04-2004	Kuroki, Yoshihide	439/138
*	E	US-2002/0123256 A1	09-2002	Brickett, Benjamin P.	439/140
*	F	US-2003/0119348 A1	06-2003	Kameda, Yasutoshi	439/137
*	G	US-6,733,311 B2	05-2004	Kameda, Yasutoshi	439/140
*	H	US-6,908,342 B2	06-2005	Shimada, Tsutomu	439/141
*	I	US-6,109,940 A	08-2000	Chad et al.	439/141
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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